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PATENT TRADEMARK OFFICE

Patent

Case No.: 57181US002

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

First Named Inventor: BAUDE, PAUL F.

Application No.: 10/076003

Group Art Unit: 2814

Filed: February 14, 2002

Examiner: H. Trinh

Title: APERTURE MASKS FOR CIRCUIT FABRICATION

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

CERTIFICATE OF MAILING

I hereby certify that this correspondence is being deposited with the United States Postal Service as First Class Mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on:

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Date

Signed by: Hylis H. Froelke

Dear Sir:

Pursuant to 37 CFR §§ 1.56, 1.97, and 1.98, enclosed is a completed Form PTO-1449, citing references submitted for consideration by the Examiner. A copy of each cited reference is also enclosed. It is respectfully requested that the Examiner initial and return the enclosed Form PTO-1449 to indicate that each reference has been considered.

This Information Disclosure Statement is being mailed after receipt of a first Office Action on the merits, but prior to the mailing of a Notice of Allowance under 37 CFR § 1.311. Please charge the fee for consideration of an Information Disclosure Statement set forth in 37 CFR § 1.17(p) to Deposit Account No. 13-3723, and if necessary, please charge any additional fees, or credit any overpayment to Deposit Account No. 13-3723. One copy of this sheet marked duplicate is also enclosed.

09/16/2003 DTESSEN1 00000003 133723 10076003

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Date

September 9, 2003

Respectfully submitted,

By:

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Office of Intellectual Property Counsel
3M Innovative Properties Company
Facsimile No.: 651-736-3833

**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

Filing Date

February 14, 2002

First Named Invent r

Baud , Paul F.

Art Unit

2814

Examiner Name

H. Trinh

Attorney Case Number

57181US002

(Use as many sheets as necessary)

Page 1 of 1

U.S. Patent Documents

Exam. Init.*	Cite No.	Document Number	Publication Date or Issue Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Doc. Number-(Kind Code if Known)			
	A1	US- 2001/0023090 A1	09/20/2001	Lee	
	A2	US- 4,684,435	08/04/1987	Kishi et al.	
	A3	US- 5,626,784	05/06/1997	Simons	
	A4	US- 6,224,448 B1	05/01/2001	Tada et al.	
	A5	US- 6,255,775 B1	07/03/2001	Ikuko et al.	
	A6	US-			
	A7	US-			
	A8	US-			
	A9	US-			
	A10	US-			
	A11	US-			

Foreign Patent Documents

Exam. Init.*	Cite No.	Foreign Patent Document		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	Translation (Check if yes)
		Ctry. Code	Number-KindCode (if known)				
	B1	JP	61-130480	06/18/1986			English Abstract
	B2	DE	31 28 982 A1	02/10/1983			English Abstract
	B3	GB	2 276 589 A	10/05/1994			
	B4	EP	1 003 221 A2	05/24/2000			
	B5						
	B6						
	B7						

OTHER PRIOR ART -- NON PATENT LITERATURE DOCUMENTS

Exam. Init.*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published
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*Examiner:

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